

AO4468





General Description

The AO4468 uses advanced trench technology to provide excellent R_{DS(ON)} and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance. Standard Product AO4468 is Pb-free (meets ROHS & Sony 259 specifications). AO4468L is a Green Product ordering option. AO4468 and AO4468L are electrically identical.

Features

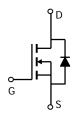
 $V_{DS}(V) = 30V$

 $I_D = 11.6A$

 $(V_{GS} = 10V)$ $R_{DS(ON)} < 14m\Omega$ $(V_{GS} = 10V)$

 $R_{DS(ON)} < 22m\Omega$ (V_{GS} = 4.5V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol Maximum		Units				
Drain-Source Voltage		V_{DS}	30	V				
Gate-Source Voltage		V_{GS}	±20	V				
Continuous Drain	T _A =25°C		11.6					
Current ^A	T _A =70°C	I_{D}	9.2	Α				
Pulsed Drain Current B		I_{DM}	50	1				
	T _A =25°C	Ь	3.1	14/				
Power Dissipation	T _A =70°C	P _D	2	- W				
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C				

Thermal Characteristics									
Parameter	Symbol	Тур	Max	Units					
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	31	40	°C/W				
Maximum Junction-to-Ambient ^A	Steady-State		59	75	°C/W				
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	16	24	°C/W				

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	rameter Conditions		Тур	Max	Units				
STATIC PARAMETERS										
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V		0.003	1					
		T _J =55°C			5	μΑ				
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V			±100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=10mA$	1.5	2	3	V				
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V	50			Α				
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =11.6A		11	14	mΩ				
		T _J =125°C		17	21	11122				
		V_{GS} =4.5V, I_D =10A		17.4	22	mΩ				
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =11.6A		19		S				
V_{SD}	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.73	1	V				
I_S	Maximum Body-Diode Continuous Current				4.5	Α				
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			955	1200	pF				
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		145		pF				
C _{rss}	Reverse Transfer Capacitance			112		pF				
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		0.5	0.85	Ω				
SWITCHI	NG PARAMETERS									
$Q_g(10V)$	Total Gate Charge			17	24	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =11.6A		9	12	nC				
Q_{gs}	Gate Source Charge	VGS=10V, VDS=10V, ID=11.0A		3.4		nC				
Q_{gd}	Gate Drain Charge			4.7		nC				
t _{D(on)}	Turn-On DelayTime			5	6.5	ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.30 Ω ,		6	7.5	ns				
$t_{D(off)}$	Turn-Off DelayTime	$R_{GEN}=3\Omega$		19	25	ns				
t _f	Turn-Off Fall Time			4.5	6	ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =11.6A, dI/dt=100A/μs		19	21	ns				
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =11.6A, dI/dt=100A/μs		9	12	nC				

A: The value of R $_{8JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t $_{\infty}$ 10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using 80 $\,\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The SOA curve provides a single pulse rating. Rev 0 : Apr 2006

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

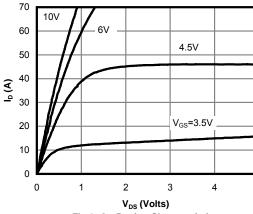
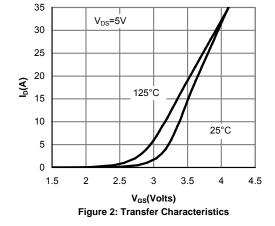


Fig 1: On-Region Characteristics



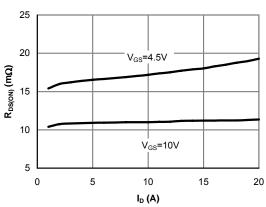


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

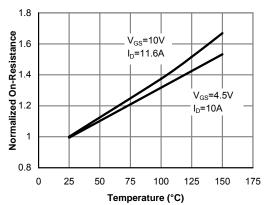


Figure 4: On-Resistance vs. Junction Temperature

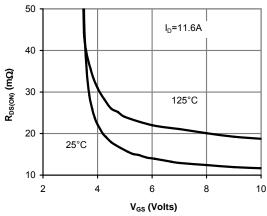


Figure 5: On-Resistance vs. Gate-Source Voltage

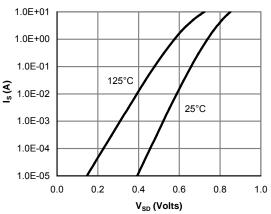
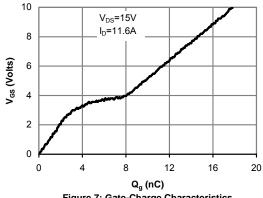


Figure 6: Body-Diode Characteristics

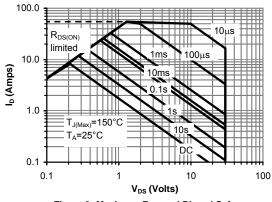
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



1500 1250 Ciss Capacitance (pF) 1000 750 500 $\mathsf{C}_{\mathsf{oss}}$ 250 0 0 5 10 15 20 25 30 V_{DS} (Volts)

Figure 7: Gate-Charge Characteristics





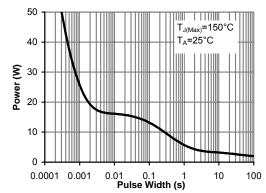


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

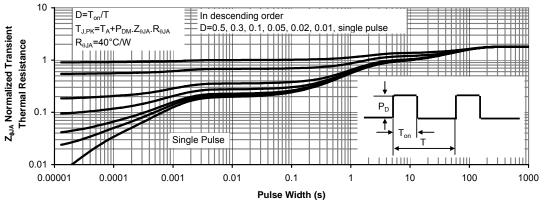


Figure 11: Normalized Maximum Transient Thermal Impedance